Designation: E 227 – 90 (Reapproved 1996)

Standard Test Method for Optical Emission Spectrometric Analysis of Aluminum and Aluminum Alloys by the Point-to-Plane Technique¹

This standard is issued under the fixed designation E 227; the number immediately following the designation indicates the year of original adoption or, in the case of revision, the year of last revision. A number in parentheses indicates the year of last reapproval. A superscript epsilon (ϵ) indicates an editorial change since the last revision or reapproval.

This standard has been approved for use by agencies of the Department of Defense.

1. Scope

1.1 This test method covers the spectrometric analysis of aluminum and aluminum alloys for the following elements in the concentration ranges indicated:

	Concentration		
Element	Range, %		
Copper	0.001 to 30.0		
Silicon	0.001 to 14.0		
Magnesium	0.001 to 11.0		
Zinc	0.001 to 10.0		
Nickel	0.001 to 10.0		
Manganese	0.001 to 8.0		
Tin	0.001 to 7.5		
Silver	0.001 to 5.0		
Iron	0.001 to 4.0		
Chromium	0.001 to 4.0		
Cadmium	0.001 to 2.0		
Cobalt	0.001 to 2.0		
Beryllium	0.001 to 1.2		
Zirconium	0.001 to 1.0		
Lead	0.002 to 0.7		
Bismuth	0.001 to 0.7		
Titanium	0.001 to 0.5		
Calcium	0.001 to 0.2		
Barium	0.001 to 0.05		
Boron	0.001 to 0.05		
Gallium	0.001 to 0.05		
Sodium	0.001 to 0.05		
Vanadium	0.001 to 0.05		

1.2 The test method is applicable primarily to the control analysis of chill-cast samples. Other forms may be analyzed, provided that (I) they are sufficiently massive to prevent undue heating, (2) they permit machining flat surfaces having a minimum dimension of approximately 16 mm (1.6 in.), and (3) reference materials of similar metallurgical condition and chemical composition are available.

1.3 This standard does not purport to address all of the safety concerns, if any, associated with its use. It is the responsibility of the user of this standard to establish appropriate safety and health practices and determine the applicability of regulatory limitations prior to use.

2. Referenced Documents

- 2.1 ASTM Standards:
- $E\,130$ Practice for Designation of Shapes and Sizes of Graphite $Electrodes^2$
- E 135 Terminology Relating to Analytical Chemistry for Metals, Ores, and Related Materials²
- E 158 Practice for Fundamental Calculations to Convert Intensities into Concentrations in Optical Emission Spectrochemical Analysis²
- E 172 Practice for Describing and Specifying the Excitation Source in Emission Spectrochemical Analysis²
- E 305 Practice for Establishing and Controlling Spectrochemical Analytical Curves²
- E 607 Test Method for Optical Emission Spectrometric Analysis of Aluminum and Aluminum Alloys by the Point-to-Plane Technique, Nitrogen Atmosphere³
- E 716 Practices for Sampling Aluminum and Aluminum Alloys for Spectrochemical Analysis³
- E 876 Practice for Use of Statistics in the Evaluation of Spectrometric Data³

3. Terminology

3.1 Definitions-Refer to Terminology E 135.

4. Summary of Test Method

4.1 A self-initiating oscillatory capacitor discharge or triggered capacitor discharge is produced between a prepared flat surface of the sample and the tip of a shaped graphite electrode. The radiant energies of selected analytical lines and an internal standard line are measured by photomultipliers. The output current of each tube during the exposure period is accumulated and stored as a charge on an associated capacitor. At the end of the exposure period, the capacitor potentials corresponding to the analytical lines relative to the potential for the internal standard line are automatically measured and recorded. The recording system may be calibrated in terms of relative radiant energies or in percent concentration. Refer to Method E 607 for the analysis of aluminum and its alloys using a nitrogen atmosphere.

¹ This test method is under the jurisdiction of ASTM Committee E-1 on Analytical Chemistry for Metals, Ores, and Related Materials and is the direct responsibility for Subcommittee E01.04 on Aluminum and Magnesium.

Current edition approved Jan. 26, 1990. Published March 1990. Originally published as E 227 – 67 T. Last previous edition E 227 – 67 $(1982)^{\epsilon_1}$.

² Annual Book of ASTM Standards, Vol 03.05.

³ Annual Book of ASTM Standards, Vol 03.06.



TABLE 1 Spectrometer Characteristics

	Type A ^A	Type B^A	Type C ^A
Focal length, m	1.5	1.5	2.0
Concave grating, grooves/mm, nominal (Note 2)	1000	1000	1000
Reciprocal linear dispersion, A/mm	6.95	6.95	5.2
Primary slit width, µm	50	50	50
Secondary slit width, µm	150	150	150
Focal length, condensing lens, mm, approx	200	130	230
Wavelength coverage, Å	2000 to 8000	2100 to 6800	1966 to 8750
Maximum number of multiplier phototube	35	40	68

^A A 1.5-m Production Control Quantometer (Type A), a 1.5-m Industrial Research Quantometer (Type B), or a 2-m Production Control Quantometer (Type C), manufactured by Applied Research Labs., Glendale Calif., has been found suitable for this purpose.

5. Significance and Use

5.1 This test method is suitable for manufacturing control, material or product acceptance, and research and development. Its use over several years has shown that both its precision and accuracy are well within expected levels.

5.2 It is assumed that all who use this method will be trained analysts capable of performing laboratory procedures skillfully and safely and that work will be performed in a properly equipped laboratory.

6. Apparatus

6.1 Sample Preparation Equipment:

6.1.1 Sample Molds-Refer to Practices E 716.

6.1.2 Lathe-Refer to Practices E 716.

6.2 *Electrode Cutter*, to shape the end of a 6.15-mm (0.242-in.) diameter graphite rod to the configuration of the Type C-5a electrode as described in Practice E 130.

6.3 *Excitation Source*, providing a self-initiating oscillatory capacitor discharge and a spark-initiated triggered capacitor discharge with the parameters described in 10.2, or equivalent.

6.4 *Excitation Stand, Petrey stand* ⁴ or other suitable stand for mounting in optical alignment a flat surface of the specimen in opposition to a graphite counter electrode. A water-cooled aluminum upper support shall be equipped with a clamp to hold the sample in a slightly inclined position, so arranged that an extension of the plane of the machined sample surface passes through the top of the condensing lens, and the center of the spark column is on the optical axis. A gage shall be provided to position the lower electrode so as to produce a 3.0-mm (0.12-in.) gap.

6.5 *Spectrometer*, having characteristics equivalent to those listed in Table 1.

6.6 *Measuring System*, consisting of photomultipliers having individual dynode voltage adjustment, capacitors on which the output of each photomultiplier is stored, an amplifier and recording system suitable for registering a function of the voltage on the capacitors, and the necessary switching arrangements to provide the desired sequence of operation. There may be provison for switching pairs of zero and gain controls into the amplifier circuit.

6.6.1 The dynode adjustment for each photomultiplier shall control its output. The rheostat used for this purpose may be referred to as the attenuator.

6.6.2 More than one readout channel may be needed for each photomultiplier if the readout is controlled with gain and zero controls. This permits defining more than one concentration range for an element. The channel layout shall be designed to suit the individual application. A typical design for an aluminum foundry is shown in Table 2.

NOTE 1—Although line spacings may be nominally identical, they may differ slightly, depending on the manufacturer.

TABLE 2	Typical C	hannel	Layout	for A	luminum	Foundr	У
---------	-----------	--------	--------	-------	---------	--------	---

Element	Wavelength, Å	Self-Initating Triggered Oscillatory Capacitor Capacitor Discharge Discharge
		ConcentrationConcentrationRange, %Range, %
Silicon	Si 2881.58 Si 3905.53 Si 3905.53	0.03 to 1.5 0.50 to 4.0 3.0 to 12.0
Iron	Fe 2395.62	0.03 to 2.0
Copper	Cu 3273.96 Cu 5105.54 Cu 5105.54	0.001 to 0.40 0.05 to 5.0 4.0 to 15.0
Manganese	Mn 2593.73 Mn 3460.33	0.01 to 0.50 0.001 to 0.05 0.20 to 2.0
Magnesium	Mg 2852.13 Mg 5183.62 Mg 5183.62	0.001 to 0.50 0.30 to 5.0 4.0 to 11.0
Chromium	Cr 4254.35	0.01 to 1.0
Nickel	Ni 3414.76 Ni 2316.04	0.01 to 1.0 0.001 to 0.05 0.50 to 5.0
Zinc	Zn 3345.02 Zn 4810.53 Zn 4810.53	0.01 to 0.50 0.001 to 0.05 0.20 to 4.0 3.0 to 8.5
Titanium Vanadium Lead	Ti 3372.80 V 4379.24 Pb 4057.82	0.01to0.40.001to0.050.01to0.200.001to0.050.01to1.00.001to0.05
Tin	Sn 3175.02 Sn 3175.02 ^A	0.01to1.00.001to0.051.0to8.00.001to0.05
Boron Beryllium Sodium Calcium Bismuth Gallium	B 2497.73 Be 3130.42 Na 5889.95 Ca 3933.67 Bi 3067.72 Ga 2943.64	0.01 to 0.10 0.001 to 0.05 0.001 to 0.05 0.001 to 0.05 0.001 to 0.05 0.001 to 0.05 0.01 to 0.05 0.001 to 0.05 0.01 to 1.0 0.001 to 0.05 0.001 0.01 to 0.10 0.001 to 0.05 0.05
Zirconium Cadmium Aluminum	Zr 3391.98 Cd 5035.82 Al 2567.99 ⁴	0.01 to 1.0 0.001 to 0.05 0.01 to 1.5 0.005 to 0.05 internal standard internal standard

A Second order.

⁴ Churchill, J. R., "Techniques of Quantitative Spectrochemical Analysis," *Industrial and Engineering Chemistry*, Analytical Edition, Vol 16, 1944, pp. 653–670.

6.6.3 For an instrument using a fixed integration time, as is typical in a computer readout, the ratio of the radiant energy of the analytical line to that of the internal standard will be calculated from the voltages developed on the integrators. For an instrument in which integration is controlled by the internal

standard, the reading displayed for each channel will be, in effect, a relative ratio of radiant energy. In a special application with a strip-chart recorder, the chart paper may be graduated in units of concentration.

Element	Wav	Wavelengths of Suitable Lines, Å	Concentration	Background Equivalent ^A %			Shape of Analytical
	Line		Range, %	1.5-m Spectrometer	2.0-m Spectrometer	Detection Limit ^a %	Curves
Silicon	Si Si Si	2516.12 2881.58 3905.53	0.001 to 14.0 0.001 to 14.0 0.50 to 14.0	 0.05 1.2	 0.03 	0.0005 0.0005 	nonlinear nonlinear linear
Iron	Fe Fe	2382.04 2395.62	0.001 to 4.0 0.001 to 4.0	0.02		0.0004	nonlinear nonlinear
	Fe	3020.64	0.01 to 1.0		0.02		nonlinear
Copper	Cu Cu Cu	2247.00 3273.96 5105.54	0.01 to 5.0 0.001 to 1.5 0.05 to 30.0	0.01 0.75	0.01 0.54	 0.0003 	nonlinear nonlinear linear to 14 %
Manganese	Mn Mn	2593.73 3460.33	0.001 to 8.0 0.05 to 8.0	0.01	0.10	0.0002 	nonlinear linear
Magnesium	Mg Mg Mg Mg	2795.53 2852.13 5167.34 5172.70 5183.62	0.001 to 1.5 0.001 to 1.5 0.05 to 11.0 0.05 to 11.0 0.05 to 11.0	 0.003 0.08	 0.04	 0.00006 	nonlinear nonlinear linear to 8 % linear to 8 % linear to 8 %
Chromium	Cr Cr	2766.54 4254.35	0.10 to 4.0 0.001 to 4.0	 0.05	 0.02	 0.0005	nonlinear nonlinear
Nickel	Ni Ni Ni	2316.04 3414.76 3515.05	0.10 to 10.0 0.001 to 3.0 0.001 to 3.0	0.05 0.05 0.12	 	0.0003 0.001	nonlinear nonlinear nonlinear
Zinc	Zn Zn Zn	2138.56 3345.02 4810.53	0.001 to 0.5 0.001 to 10.0 0.01 to 8.0	 0.10 0.13	 0.06	 0.001 	nonlinear linear linear
Titanium	Ti Ti	3372.80 3685.20	0.001 to 0.5 0.01 to 1.0	0.02		0.0003 0.0003	linear linear
Vanadium	V V	3183.41 4379.24	0.001 to 0.05 0.001 to 0.05	 0.08		 0.001	linear linear
Lead Tin Boron	Pb Sn B	4057.82 3175.02 2497.73	0.002 to 0.7 0.001 to 7.5 0.001 to 0.05	0.08 0.15 0.01	 	0.001 0.001 0.0002	linear linear linear
Beryllium	Be Be	2348.61 3130.42	0.001 to 0.05 0.001 to 1.2			 0.0001	linear linear
Sodium Calcium Bismuth	Na Ca Bi	5889.95 3933.67 3067.72	0.001 to 0.05 0.001 to 0.2 0.001 to 0.7	0.002 0.002 0.07	 	0.00004 0.00004 0.001	nonlinear nonlinear linear
Gallium	Ga Ga	2874.24 2943.64	0.001 to 0.05 0.001 to 0.05			0.001 0.001	linear linear
Zirconium	Zr Zr	3391.98 3438.23	0.001 to 1.0 0.001 to 1.0	0.020 0.041		0.0006 0.001	linear linear
Cadmium	Cd Cd	2288.02 5085.82	0.01 to 2.0 0.01 to 2.0	0.03 0.10		0.01 	nonlinear linear
Cobalt	Co Co	3453.50 3465.80	0.001 to 2.0 0.001 to 2.0	0.01 0.17		0.001 0.001	nonlinear nonlinear
Barium	Ва	4554.04	0.001 to 0.05	0.007		0.001	linear

TABLE 3 Analytical Lines Background Equivalents and Detection Limits Using a Self-Initiating Oscillatory Capacitor Discharge